

#### **SAR EVALUATION REPORT**

### FCC 47 CFR § 2.1093 IEEE Std 1528-2013

# For **SMARTPHONE**

FCC ID: BCG-E4032A, BCG-E3999A, BCG-E4031A

Model Name: A2635, A2634, A2631, A2633

Report Number: 13583999-S1V4 Issue Date: 8/17/2021

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### **Revision History**

Rev.	Date	Revisions	Revised By
V1	8/5/2021	Initial Issue	
V2	8/12/2021	Section 1 – updated highest reported SAR table. Section 7 – Added test rationale Section 8 – updated SAR table	Devin Chang
V3	8/13/2021	Section 8.2 – Corrected LTE B48 SAR value	Dave Weaver
V4	8/17/2021	Section 1 – Updated text	Dave Weaver

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### 1. Attestation of Test Results

Applicant Name	APPLE INC.								
	BCG-E4032A, BCG-E3999A, BCG-E4031A								
FCC ID	BCG-E4032A,	BCG-E3999A, E	3CG-E4031A						
Model Name	A2635, A2634	, A2631, A2633							
Applicable Standards	FCC 47 CFR §	§ 2.1093							
	Published RF	exposure KDB ¡	orocedures						
	IEEE Std 1528	3-2013							
			SAR Lim	its (W/Kg)					
Exposure Category	Peak spatial-average(1g of tissue)			Extremities (hands, wrists, ankles, etc.) (10g of tissue)					
General population / Uncontrolled exposure	1.6 4								
DE Eversoure Conditions	Equipment Class - Highest Reported SAR (W/kg)								
RF Exposure Conditions	TNE	PCE	CBE	DTS	NII	DSS			
Worst Case from BCG-E3997A	0.955	0.959	0.951	1.181	1.172	1.138			
Variant Models		W	orst-Case SAR	for Variant Mode	els				
BCG-E4032A (A2635, A2634)	0.991	0.961	0.909	1.077	1.107	1.157			
BCG-E3999A (A2631)	0.982 0.974 0.995 1.190 1.043 1.154				1.154				
BCG-E4031A (A2633)	0.994	0.895	0.827	1.065	1.056	0.978			
Date Tested	7/9/2021 to 7/30/2021								
Test Results	Pass				Pass				

This application for certification is leveraging the data reuse procedure from TCB workshop April 2021; RF Exposure Procedures (Remarks on Test Reductions via Data Referencing for Closely Related Products) based on reference FCC ID: **BCG-E3997A** (UL report# 13571607-S1) to cover variant FCC ID: **BCG-E4032A**, **BCG-E3999A** and **BCG-E4031A**. The major difference between the parent/reference model and the variant model is the depopulation in the variant model of the mmWave transmitter. All other circuitry and features are identical. The data reuse test plan was approved via manufacturer KDB inquiry.

UL Verification Services Inc. tested the above equipment in accordance with the requirements set forth in the above standards. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

This report contains data provided by the customer which can impact the validity of results. UL Verification Services Inc. is only responsible for the validity of results after the integration of the data provided by the customer.

The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. All samples tested were in good operating condition throughout the entire test program. Measurement Uncertainties are published for informational purposes only and were not taken into account unless noted otherwise.

This document may not be altered or revised in any way unless done so by UL Verification Services Inc. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Verification Services Inc. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by A2LA, NIST, any agency of the Federal Government, or any agency of the U.S. government.

Approved & Released By:	Prepared By:
Jen Cary	You Ar
Devin Chang	George Hu
Senior Test Engineer	Lab Technician
UL Verification Services Inc.	UL Verification Services Inc.

### 2. Test Specification, Methods and Procedures

The tests documented in this report were performed in accordance with FCC 47 CFR § 2.1093, IEEE STD 1528-2013, the following FCC Published RF exposure KDB procedures:

- o 248227 D01 802.11 Wi-Fi SAR v02r02
- o 447498 D01 General RF Exposure Guidance v06
- 447498 D03 Supplement C Cross-Reference v01
- 648474 D04 Handset SAR v01r03
- 865664 D01 SAR measurement 100 MHz to 6 GHz v01r04
- o 865664 D02 RF Exposure Reporting v01r02
- 941225 D01 3G SAR Procedures v03r01
- 941225 D05 SAR for LTE Devices v02r05
- 941225 D05A LTE Rel.10 KDB Inquiry Sheet v01r02
- 941225 D06 Hotspot Mode v02r01

#### In addition to the above, the following information was used:

- o <u>TCB workshop</u> October 2014; RF Exposure Procedures (Other LTE Considerations)
- TCB workshop April 2015; RF Exposure Procedures (Overlapping LTE Bands)
- o TCB workshop October 2015; RF Exposure Procedures (KDB 941225 D05A)
- TCB workshop April 2016; RF Exposure Procedures (LTE Carrier Aggregation for DL)
- TCB workshop October 2016; RF Exposure Procedures (LTE Carrier Aggregation for UL)
- o TCB workshop October 2016; RF Exposure Procedures (Bluetooth Duty Factor)
- o TCB workshop October 2016; RF Exposure Procedures (DUT Holder Perturbations)
- TCB workshop May 2017; RF Exposure Procedures (Broadband Liquid Above 3 GHz)
- o TCB workshop May 2017; RF Exposure Procedures (LTE Band 41 Power Class 2)
- TCB workshop November 2017; RF Exposure Procedures (LTE UL/DL Carrier Aggregation SAR)
- TCB workshop April 2018; RF Exposure Procedures (LTE DL CA SAR Test Exclusion)
- TCB workshop October 2018; RF Exposure Procedures (LTE Inter-Band Uplink Carrier Aggregation Interim Procedures)
- o TCB workshop April 2019; RF Exposure Procedures (802.11ax SAR Testing)
- TCB workshop November 2019; RF Exposure Policy Updates (5G NR FR1 NSA EN-DCUE SAR Evaluations)
- TCB workshop April 2021; RF Exposure Procedures (Remarks on Test Reductions via Data Referencing for Closely Related Products)

### 3. Facilities and Accreditation

The test sites and measurement facilities used to collect data are located at

47173 Benicia Street	47266 Benicia Street
SAR Lab A	SAR Lab 1
SAR Lab B	SAR Lab 2
SAR Lab C	SAR Lab 3
SAR Lab D	SAR Lab 4
SAR Lab E	SAR Lab 5
SAR Lab F	SAR Lab 6
SAR Lab G	SAR Lab 8
SAR Lab H	SAR Lab 9
	SAR Lab 10
	SAR Lab 11
	SAR Lab 12
	SAR Lab 13
	SAR Lab 14
	SAR Lab 15
	SAR Lab 16

UL Verification Services Inc. is accredited by A2LA, Certificate Number 0751.05

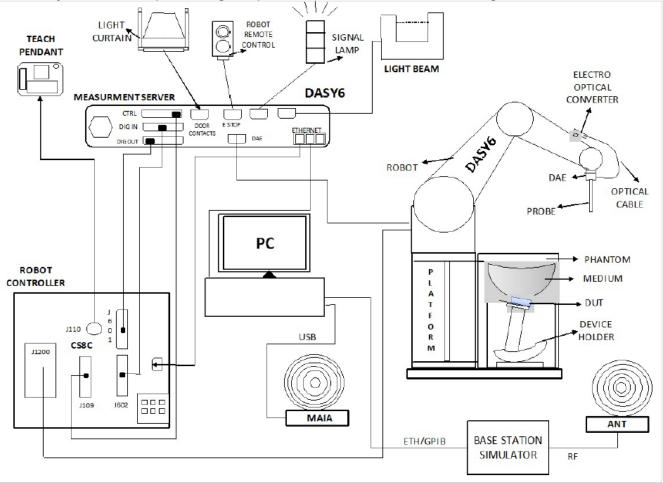
The Test Lab Conformity Assessment Body Identifier (CABID)

Location	CABID	Company Number
47173 Benicia Street, Fremont, CA, 94538 UNITED STATES	1100104	2324A
47266 Benicia Street, Fremont, CA, 94538 UNITED STATES	US0104	22541

### 4. SAR Measurement System & Test Equipment

### 4.1. SAR Measurement System

The DASY system used for performing compliance tests consists of the following items:



- A standard high precision 6-axis robot with controller, teach pendant and software. An arm extension for accommodating the data acquisition electronics (DAE).
- An isotropic Field probe optimized and calibrated for the targeted measurement.
- A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, ADconversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-optical converter (EOC) performs the conversion from optical to electrical signals for the digital communication to the DAE. To use optical surface detection, a special version of the EOC is required. The EOC signal is transmitted to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- The Light Beam used is for probe alignment. This improves the (absolute) accuracy of the probe positioning.
- A computer running Win7, Win10 and the DASY52<sup>1</sup> and DASY6<sup>2</sup> software.
- Remote control and teach pendant as well as additional circuitry for robot safety such as warning lamps, etc.
- The phantom, the device holder and other accessories according to the targeted measurement.

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<sup>&</sup>lt;sup>1</sup> DASY52 software used: DASY52.10.4 & S 14.6.14 and older generations.

<sup>&</sup>lt;sup>2</sup> DASY6 software used: DASY6.14 & S 14.6.14 and older generations.

#### 4.2. SAR Scan Procedures

#### **Step 1: Power Reference Measurement**

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. The minimum distance of probe sensors to surface is 2.1 mm. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

#### Step 2: Area Scan

The Area Scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum locations even in relatively coarse grids. When an Area Scan has measured all reachable points, it computes the field maximal found in the scanned area, within a range of the global maximum. The range (in dB) is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE Standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan). If only one Zoom Scan follows the Area Scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of Zoom Scans has to be increased accordingly.

Area Scan Parameters extracted from KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz

	≤ 3 GHz	> 3 GHz	
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	5 ± 1 mm	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$	
Maximum probe angle from probe axis to phantom surface normal at the measurement location	30° ± 1°	20° ± 1°	
	≤ 2 GHz: ≤ 15 mm 2 – 3 GHz: ≤ 12 mm	$3 - 4 \text{ GHz:} \le 12 \text{ mm}$ $4 - 6 \text{ GHz:} \le 10 \text{ mm}$	
Maximum area scan spatial resolution: $\Delta x_{Area}$ , $\Delta y_{Area}$	When the x or y dimension of the test device, in the measurement plane orientation, is smaller than the above, the measurement resolution must be $\leq$ the corresponding x or y dimension of the test device with at least one measurement point on the test device.		

#### Step 3: Zoom Scan

Zoom Scans are used to assess the peak spatial SAR values within a cubic averaging volume containing 1 g and 10 g of simulated tissue. The Zoom Scan measures points (refer to table below) within a cube whose base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the Zoom Scan evaluates the averaged SAR for 1 g and 10 g and displays these values next to the job's label.

Zoom Scan Parameters extracted from KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz

		≤3 GHz	> 3 GHz	
Maximum zoom scan spatial resolution: $\Delta x_{Zoom}$ , $\Delta y_{Zoom}$		$\leq$ 2 GHz: $\leq$ 8 mm 2 – 3 GHz: $\leq$ 5 mm	$3 - 4 \text{ GHz: } \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz: } \le 4 \text{ mm}^*$	
	uniform grid: $\Delta z_{Zoom}(n)$		≤ 5 mm	$3 - 4 \text{ GHz: } \le 4 \text{ mm}$ $4 - 5 \text{ GHz: } \le 3 \text{ mm}$ $5 - 6 \text{ GHz: } \le 2 \text{ mm}$
Maximum zoom scan spatial resolution, normal to phantom surface	graded grid $\Delta$	Δz <sub>Zoom</sub> (1): between 1 <sup>st</sup> two points closest to phantom surface	≤ 4 mm	$3 - 4 \text{ GHz: } \le 3 \text{ mm}$ $4 - 5 \text{ GHz: } \le 2.5 \text{ mm}$ $5 - 6 \text{ GHz: } \le 2 \text{ mm}$
		Δz <sub>Zoom</sub> (n>1): between subsequent points	$\leq 1.5 \cdot \Delta z_{Zoom}(n-1)$	
Minimum zoom scan volume	x, y, z		3 – 4 GHz: ≥ 28 m ≥ 30 mm 4 – 5 GHz: ≥ 25 m 5 – 6 GHz: ≥ 22 m	

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

#### Step 4: Power drift measurement

The Power Drift Measurement measures the field at the same location as the most recent power reference measurement within the same procedure, and with the same settings. The Power Drift Measurement gives the field difference in dB from the reading conducted within the last Power Reference Measurement. This allows a user to monitor the power drift of the device under test within a batch process. The measurement procedure is the same as Step 1.

When zoom scan is required and the <u>reported</u> SAR from the <u>area scan based 1-g SAR estimation</u> procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

### 4.3. Test Equipment

The measuring equipment used to perform the tests documented in this report has been calibrated in accordance with the manufacturers' recommendations, and is traceable to recognized national standards.

**Dielectric Property Measurements** 

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
Netw ork Analyzer	Rohde & Schwarz	ZNLE6	101273	2/26/2022
Dielectric Probe kit	SPEAG	DAK-3.5	1087	11/12/2021
Shorting block	SPEAG	DAK-3.5 Short	SM DAK200BA	11/12/2021
Thermometer	Fischer Scientific	4242	150378159	8/5/2021
Netw ork Analyzer	Rohde & Schwarz	ZNLE6	101274	2/26/2022
Dielectric Probe kit	SPEAG	DAK-3.5	1082	9/9/2021
Shorting block	SPEAG	DAK-3.5 Short	SM DAK200DA	9/9/2021
Thermometer	Control Company	15-078-179	170064398	7/30/2021 *

#### Note(s):

**System Check** 

Oystein Oncok				
Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
Signal Generator	Keysight Technologies	N5181A-506	MY50140610	1/21/2022
Power Meter	Keysight Technologies	N1912A	MY50001018	1/21/2022
Power Sensor	Keysight Technologies	N1921A	MY53020038	1/28/2022
DC Power Supply	Ametek	XT15-4	1802A01877	N/A
Amplifier	Miteq	AMF-4D-00400600-50-30P	1795092	N/A
Signal Generator	Rohde & Schwarz	SMB100A03	180969	2/16/2022
3-Path Diode Power Sensor	Rohde & Schwarz	NRP18A	100992	2/16/2022
Signal Generator	Rohde & Schwarz	SMB100A03	180970	2/16/2022
Power Meter	Keysight Technologies	437B	3125U11347	1/26/2022
3-Path Diode Power Sensor	Rohde & Schwarz	NRP18A	100995	2/26/2022
Bi-Directional Coupler	Werlatone	C8060-102	4063	N/A

**Lab Equipment** 

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
E-Field Probe (SAR Lab E)	SPEAG	EX3DV4	7500	3/18/2022
E-Field Probe (SAR Lab H)	SPEAG	EX3DV4	7501	3/18/2022
E-Field Probe (SAR Lab 4)	SPEAG	EX3DV4	3929	3/19/2022
E-Field Probe (SAR Lab 5)	SPEAG	EX3DV4	7498	3/18/2022
E-Field Probe (SAR Lab 7)	SPEAG	EX3DV4	7587	4/27/2022
E-Field Probe (SAR Lab 10)	SPEAG	EX3DV4	7448	2/26/2022
E-Field Probe (SAR Lab 12)	SPEAG	EX3DV4	3686	9/21/2021
Data Acquisition Electronics (SAR Lab E)	SPEAG	DAE4	1540	1/27/2022
Data Acquisition Electronics (SAR Lab H)	SPEAG	DAE4	1544	1/27/2022
Data Acquisition Electronics (SAR Lab 4)	SPEAG	DAE4	1439	7/16/2021 *
Data Acquisition Electronics (SAR Lab 5)	SPEAG	DAE4	1239	7/29/2021 *
Data Acquisition Electronics (SAR Lab 7)	SPEAG	DAE4	1472	1/28/2022
Data Acquisition Electronics (SAR Lab 10)	SPEAG	DAE4	1545	2/22/2022
Data Acquisition Electronics (SAR Lab 12)	SPEAG	DAE4	1434	10/12/2021

#### Note(s):

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<sup>\*</sup>Equipment not used past calibration due date.

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#### Lab Equipment

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
System Validation Dipole	SPEAG	D835V2	4d117	5/11/2022
System Validation Dipole	SPEAG	D835V2	4d142	8/18/2021
System Validation Dipole	SPEAG	D2450V2	706	4/23/2022
System Validation Dipole	SPEAG	D2450V2	899	4/13/2022
System Validation Dipole	SPEAG	D2600V2	1006	10/20/2021
System Validation Dipole	SPEAG	D3700V2	1039	4/16/2022
System Validation Dipole	SPEAG	D5GHzV2	1168	11/27/2021

#### **OTHER**

Name of Equipment	Manufacturer	Type/Model	T Number	Serial No.	Cal. Due Date
Wideband Radio Communication Tester	Rohde & Schwarz	CMW 500	959	137873-WG	2/19/2022
Wideband Radio Communication Tester	Rohde & Schwarz	CMW 500	268	124593-ss	2/26/2022
Wideband Radio Communication Tester	Rohde & Schwarz	CMW 500	1871	164541	2/24/2022
Wideband Radio Communication Tester	Rohde & Schwarz	CMW 500	978	137877-ms	2/16/2022
Wideband Radio Communication Tester	Rohde & Schwarz	CMW 500	960	135384-pJ	2/28/2022

### 5. Measurement Uncertainty

Per KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz, when the highest measured 1-g SAR within a frequency band is < 1.5 W/kg and the measured 10-g SAR within a frequency band is < 3.75 W/kg. The expanded SAR measurement uncertainty must be  $\leq$  30%, for a confidence interval of k = 2. If these conditions are met, extensive SAR measurement uncertainty analysis described in IEEE Std 1528-2013 is not required in SAR reports submitted for equipment approval.

Therefore, the measurement uncertainty is not required.

### 6. Dielectric Property Measurements & System Check

### 6.1. Dielectric Property Measurements

The temperature of the tissue-equivalent medium used during measurement must also be within  $18^{\circ}$ C to  $25^{\circ}$ C and within  $\pm 2^{\circ}$ C of the temperature when the tissue parameters are characterized.

The dielectric parameters must be measured before the tissue-equivalent medium is used in a series of SAR measurements. The parameters should be re-measured after each 3-4 days of use; or earlier if the dielectric parameters can become out of tolerance; for example, when the parameters are marginal at the beginning of the measurement series.

Tissue dielectric parameters were measured at the low, middle and high frequency of each operating frequency range of the test device.

The dielectric constant ( $\epsilon$ r) and conductivity ( $\sigma$ ) of typical tissue-equivalent media recipes are expected to be within  $\pm$  5% of the required target values; but for SAR measurement systems that have implemented the SAR error compensation algorithms documented in IEEE Std 1528-2013, to automatically compensate the measured SAR results for deviations between the measured and required tissue dielectric parameters, the tolerance for  $\epsilon$ r and  $\sigma$  may be relaxed to  $\pm$  10%. This is limited to frequencies  $\leq$  3 GHz.

#### **Tissue Dielectric Parameters**

FCC KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz

Target Frequency (MHz)	ŀ	-lead	Во	dy
ranger i requeitcy (Mi iz)	$\varepsilon_{\rm r}$	σ (S/m)	E <sub>r</sub>	σ (S/m)
150	52.3	0.76	61.9	0.80
300	45.3	0.87	58.2	0.92
450	43.5	0.87	56.7	0.94
835	41.5	0.90	55.2	0.97
900	41.5	0.97	55.0	1.05
915	41.5	0.98	55.0	1.06
1450	40.5	1.20	54.0	1.30
1610	40.3	1.29	53.8	1.40
1800 – 2000	40.0	1.40	53.3	1.52
2450	39.2	1.80	52.7	1.95
3000	38.5	2.40	52.0	2.73
5000	36.2	4.45	49.3	5.07
5100	36.1	4.55	49.1	5.18
5200	36.0	4.66	49.0	5.30
5300	35.9	4.76	48.9	5.42
5400	35.8	4.86	48.7	5.53
5500	35.6	4.96	48.6	5.65
5600	35.5	5.07	48.5	5.77
5700	35.4	5.17	48.3	5.88
5800	35.3	5.27	48.2	6.00

#### IEEE Std 1528-2013

Refer to Table 3 within the IEEE Std 1528-2013

#### IEC 62209-1

Refer to Table A.3 within the IEC 62209-1

Dielectric Property Measurements Results:

SAR		Band	nents Resi	Frequency	Relat	ive Permittivit	• • •	C	onductivity (	<b>)</b>
Lab	Date	(MHz)	Type	(MHz)	Measured	Target	Delta (%)	Measured	Target	Delta (%)
				2450	37.67	39.20	-3.90	1.79	1.80	-0.50
E	7/10/2021	2450	Head	2400	37.75	39.30	-3.94	1.75	1.75	0.13
				2480	37.62	39.16	-3.94	1.81	1.83	-1.06
				2450	37.71	39.20	-3.80	1.86	1.80	3.06
E	7/14/2021	2450	Head	2400	38.05	39.30	-3.17	1.80	1.75	2.59
				2480	37.47	39.16	-4.32	1.90	1.83	3.69
				2450	39.24	39.20	0.10	1.81	1.80	0.67
E	7/26/2021	2450	Head	2400	39.44	39.30	0.36	1.77	1.75	1.05
				2480	39.09	39.16	-0.18	1.83	1.83	-0.02
				5750	34.53	35.36	-2.35	4.96	5.21	-4.92
Н	7/10/2021	5750	Head	5700	34.62	35.42	-2.26	4.91	5.16	-4.89
				5850	34.39	35.30	-2.58	5.08	5.27	-3.55
				5750	36.83	35.36	4.15	5.43	5.21	4.15
Н	7/26/2021	5750	Head	5700	36.81	35.42	3.92	5.35	5.16	3.65
				5850	36.85	35.30	4.39	5.44	5.27	3.17
				3500	37.88	37.93	-0.13	2.87	2.91	-1.53
4	7/9/2021	3500	Head	3400	38.07	38.04	0.07	2.81	2.81	-0.12
				3600	37.80	37.82	-0.04	2.98	3.01	-0.99
				2600	37.99	39.01	-2.62	1.91	1.96	-2.81
5	7/27/2021	2600	Head	2495	38.07	39.14	-2.74	1.82	1.85	-1.71
				2690	37.74	38.90	-2.98	1.98	2.06	-3.76
				2600	38.53	39.01	-1.23	1.95	1.96	-0.57
7	7/24/2021	2600	Head	2495	38.74	39.14	-1.02	1.86	1.85	0.83
				2690	38.56	38.90	-0.87	2.00	2.06	-2.89
				835	40.36	41.50	-2.75	0.94	0.90	4.44
10	7/19/2021	835	Head	805	40.60	41.68	-2.59	0.93	0.90	3.64
				850	40.33	41.50	-2.82	0.95	0.92	3.83
				835	41.50	41.50	0.00	0.91	0.90	1.11
12	7/19/2021	835	Head	805	42.04	41.68	0.86	0.90	0.90	0.30
				850	41.36	41.50	-0.34	0.91	0.92	-0.55

### 6.2. System Check

SAR system verification is required to confirm measurement accuracy, according to the tissue dielectric media, probe calibration points and other system operating parameters required for measuring the SAR of a test device. The system verification must be performed for each frequency band and within the valid range of each probe calibration point required for testing the device. The same SAR probe(s) and tissue-equivalent media combinations used with each specific SAR system for system verification must be used for device testing. When multiple probe calibration points are required to cover substantially large transmission bands, independent system verifications are required for each probe calibration point. A system verification must be performed before each series of SAR measurements using the same probe calibration point and tissue-equivalent medium. Additional system verification should be considered according to the conditions of the tissue-equivalent medium and measured tissue dielectric parameters, typically every three to four days when the liquid parameters are re-measured or sooner when marginal liquid parameters are used at the beginning of a series of measurements.

#### **System Performance Check Measurement Conditions:**

- The measurements were performed in the flat section of the TWIN SAM or ELI phantom, shell thickness: 2.0 ±0.2 mm (bottom plate) filled with Body or Head simulating liquid of the following parameters.
- The depth of tissue-equivalent liquid in a phantom must be ≥ 15.0 cm for SAR measurements ≤ 3 GHz and ≥ 10.0 cm for measurements > 3 GHz.
- The DASY system with an E-Field Probe was used for the measurements.
- The dipole was mounted on the small tripod so that the dipole feed point was positioned below the center
  marking of the flat phantom section and the dipole was oriented parallel to the body axis (the long side of the
  phantom). The standard measuring distance was 10 mm (above 1 GHz) and 15 mm (below 1 GHz) from dipole
  center to the simulating liquid surface.
- The coarse grid with a grid spacing of 15 mm was aligned with the dipole. For 5 GHz band - The coarse grid with a grid spacing of 10 mm was aligned with the dipole.
- Special 7x7x7 (below 3 GHz) and/or 8x8x7 (above 3 GHz) fine cube was chosen for the cube.
- Distance between probe sensors and phantom surface was set to 3 mm.
   For 5 GHz band Distance between probe sensors and phantom surface was set to 2.5 mm
- The dipole input power (forward power) was 100 mW.
- The results are normalized to 1 W input power.

#### **System Check Results**

The 1-g and 10-g SAR measured with a reference dipole, using the required tissue-equivalent medium at the test frequency, must be within  $\pm 10\%$  of the manufacturer calibrated dipole SAR target. Refer to Appendix B for the SAR System Check Plots.

SAR	5.4	Tissue	Dipole Type	Dipole	M	easured Resul	ts for 1g SAR		Me	asured Result	s for 10g SAR		Plot
Lab	Date	Type	_Serial #	Cal. Due Data	Zoom Scan to 100 mW	Normalize to 1 W	Target (Ref. Value)	Delta ±10 %	Zoom Scan to 100 mW	Normalize to 1 W	Target (Ref. Value)	Delta ±10 %	No.
Е	7/10/2021	Head	D2450V2 SN:706	4/23/2022	5.470	54.70	52.30	4.59	2.480	24.80	24.50	1.22	1,2
Е	7/14/2021	Head	D2450V2 SN:899	4/13/2022	5.150	51.50	50.96	1.06	2.320	23.20	23.89	-2.89	
Е	7/26/2021	Head	D2450V2 SN:899	4/13/2022	5.570	55.70	50.96	9.30	2.510	25.10	23.89	5.06	3,4
Н	7/10/2021	Head	D5GHzV2 SN:1168 (5.75 GHz)	11/27/2021	7.940	79.40	78.00	1.79	2.330	23.30	22.40	4.02	
Н	7/26/2021	Head	D5GHzV2 SN:1168 (5.75 GHz)	11/27/2021	8.390	83.90	78.00	7.56	2.450	24.50	22.40	9.38	5,6
4	7/9/2021	Head	D3700V2 SN:1039	4/16/2022	6.840	68.40	66.40	3.01	2.570	25.70	24.00	7.08	7,8
5	7/27/2021	Head	D2600V2 SN:1006	10/20/2021	5.250	52.50	51.36	2.22	2.380	23.80	23.41	1.67	9,10
7	7/24/2021	Head	D2600V2 SN:1006	10/20/2021	4.790	47.90	51.36	-6.74	2.140	21.40	23.41	-8.59	11,12
10	7/19/2021	Head	D835V2 SN:4d117	5/11/2022	1.070	10.70	10.23	4.59	0.695	6.95	6.69	3.89	13,14
12	7/19/2021	Head	D835V2 SN:4d142	8/18/2021	0.982	9.82	9.36	4.91	0.637	6.37	6.09	4.60	15,16

#### 7. Test Rationale

### 7.1. Purpose

This application for certification is leveraging the data reuse procedure from TCB workshop April 2021; RF Exposure Procedures (Remarks on Test Reductions via Data Referencing for Closely Related Products) based on reference model FCC ID: BCG-E3997A to cover variant FCC ID: BCG-E4032A, BCG-E3999A and BCG-E4031A. The major difference between the parent model and the variant models is the depopulation in the variant model of the mmWave transmitter. All other circuitry and features are identical. The data reuse test plan was approved via manufacturer KDB inquiry.

### 7.2. Data Reuse Approach

Full RF exposure testing was performed on the parent model. The configurations with the highest SAR values for each equipment class were identified. These configurations were tested on the variant models.

The variation in SAR values was well within the uncertainty budget of the SAR test equipment. The variant SAR results and worst case parent SAR values are summarized in section 1.

### 8. Measured and Reported (Scaled) SAR Results

### 8.1. A2635 Spot Check Results

Wireless		RF Exposu	re	Pow	/ er	Dist.	Tes	st			Freq.		Pow er	(dBm)		1-g SAR	(W/kg)		10-g SAF	R (W/kg)	Plot
Technoligies	Antenn	Conditions	Mode	Мо		(mm)	Positi		Ch #.		(MHz)		e-up mit	Meas.	N	leas.	Scale	ed	Meas.	Scaled	No.
CDMA BC10	ANT2	Head	1xRTT RC SO55	Mod	e A	0	Right To	ouch	560		820.0	24	.70	24.62	0	.973	0.99	1	0.615	0.626	1
Wireless		RF Exposure	F	Pow er	Dist.	Te	st	G	Fr	eq.	RB	RB		Pow er (di	Bm)	1-g	SAR (W	/kg)	10-g S.	AR (W/kg)	Plot
Technoligies	Antenna	Conditions	Mode .	Mode	(mm)	Posit	tion	Ch #.	(M	lHz)	Allocation	offset		ie-up imit	Meas.	Meas	. s	icaled	Meas.	Scaled	No.
LTE B7	ANT2	Head	QPSK M	lode A	0	Left	Tilt	21100	25	35.0	50	24	17	'.70	16.68	0.760	) (	0.961	0.288	0.364	2
														Pow er (di	2>		SAR (W	/// \	40 = 0	AR (W/kg)	
Wireless Technoligies	Antenna	RF Exposure Conditions	Mode	Power Mode	Dist. (mm)	Te: Posit		Ch #.		eq. IHz)	RB Allocation	RB offset	Tur	o un	Meas.	I-g Meas		caled	Meas.	Scaled	Plot No.
Ü					` /				,				L	imit							
LTE B48	ANT7	Body-w orn	QPSK N	Node B	5	Rea	ar	56640	369	90.0	1	49	20	).40	19.77	0.786	6 (	0.909	0.262	0.303	3
Wireless	,	WWAN RF Exp	ocuro	Pow	vor [	Dist.	Test			Freg.		Scan	Duty	Pow e	r (dBm)		1-g SAR (	(W/kg)	10-g	SAR (W/kg)	Plot
Technoligies		Pow er Condi		Mo		mm)	Position	(	Ch #.	(MHz)			Cycle	Tune-up Limit	Meas	i. M	eas.	Scaled	Meas.	Scaled	No.
Wi-Fi 2.4 GHz	ANT4	Cell Off Hots	pot 802.11	b Mod	le B	5	Edge 2		6	2437	0.8	369 9	98.5%	21.50	19.90	0.	734	1.077	0.283	0.415	4
				•								Area Scar	,	Po	w er (dBm	1	1-g SAF	R (W/ka)	10-a	SAR (W/kg)	
Wireless Technoligies		WWAN Power Band	RF Exposure Conditions	Mode	Pow			Test osition	Ch #.			Max. SAR (W/kg)		' <u> </u>	ıp M		Meas.	Scaled		Scaled	Plot No.
Wi-Fi 5 GHz	ANT5 C	ell OFF U-NII-3	Body-w orn	802.11ac VHT80	Mod	le B	5 F	Rear	155		5775	1.450	95.19			.44	0.694	1.107	0.209	0.333	5
													Po	w er (dBm	)	1-a S	AR (W/k	a)	10-a SA	R (W/kg)	
Wireless Technoligies	Antenna	RF Exposure Conditions	Mode	Pow ei Mode			Test Position	1	Ch #.	Fre (MH		Duty Cycle	Tune-u		_	Meas.	<del></del>	aled	Meas.	Scaled	No.
Bluetooth	ANT3 Pstandlaon	Hotspot	GFSK	Mode E	В 5	5	Edge 4		39	244	1 10	00.0%	19.50	18	.37	0.892	1.1	157	0.386	0.501	6

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# 8.2. A2631 Spot Check Results

Wireless		RF Exposure		Pow e	r Dist.	Т	est			Frea.		Pow er (	(dBm)		1-g SAR	(W/kg)		10-g SAF	R (W/kg)	Plot
Technoligies	Antenn	Conditions	Mode	Mode			sition	Ch #.		(MHz)	Tund		Meas.	N	leas.	Scaled	_	Meas.	Scaled	No.
CDMA BC10	ANT2	Head	1xRTT RC3 SO55	Mode	A 0	Right	Touch	560		820.0	24.	70	24.62	0	.964	0.982		0.661	0.673	7
Wireless	Antenna	RF Exposure	Mode			est	Ch #.		eq.	RB	RB		Pow er (dB	m)	1-g	SAR (W/kg	)	10-g S/	AR (W/kg)	Plot
Technoligies	Amonna	Conditions	Node N	/lode (n	nm) Pos	sition	GI #	· (N	lHz) .	Allocation	offset	Tune Lir		Meas.	Meas.	Sca	led	Meas.	Scaled	No.
LTE B7	ANT2	Head	QPSK Mo	ode A	0 Let	ft Tilt	21100	25	35.0	50	24	17.	70	16.68	0.770	0.9	74	0.283	0.358	8
105		55.5	_								RB	F	Pow er (dB	m)	1-g :	SAR (W/kg	)	10-g SA	AR (W/kg)	
Wireless Technoligies	Antenna	RF Exposure Conditions	Mode			est sition	Ch #.		eq. Hz)	RB Allocation	offset	Tune		∕leas.	Meas.	Sca	led	Meas.	Scaled	Plot No.
LTE B48	ANT7	Body-w orn	QPSK M	ode B	5 R	ear	56640	369	90.0	1	49	20.	40 1	9.77	0.861	0.99	95	0.198	0.229	9
Wireless	,	WWAN RF Expo		Pow e	r Dist	Test			Freq.	Area	Scan	Outv	Pow er	(dBm)	1	-g SAR (W/	'kg)	10-g S	SAR (W/kg)	Plot
Technoligies	∆ ntenna I	Pow er Condition		Mode	(mm)	Positio		Ch #.	(MHz)	Max. (W/	SAR	cycle	Tune-up Limit	Meas	. Me	as. S	caled	Meas.	Scaled	No.
Wi-Fi 2.4 GHz	ANT4	Cell Off Hotsp	ot 802.11b	Mode I	В 5	Edge :	2	6	2437	0.8	69 9	8.5%	21.50	19.90	0.8	311 1	.190	0.353	0.518	10
							•				rea Scan		Pov	ver (dBm	)	1-g SAR (\	N/ka)	10 <sub>e</sub> a	SAR (W/kg)	
Wireless Technoligies	Intenna	MAN Power Band	RF Exposure Conditions	Mode	Pow er Mode	Dist. (mm)	Test Position	Ch #.			Max. SAR (W/kg)	Duty Cycle		<u>, `</u>			Scaled	Meas.	Scaled	Plot No.
Wi-Fi 5 GHz	ANT5 C	ell OFF U-NII-3		802.11ac VHT80	Mode B	5	Rear	155	5	775	1.450	95.1%		14	.44	0.654	1.043	0.197	0.314	11
Wireless		RF Exposure		Pow er	Dist.	Test			Fred	a. r	Outy	Pow	ver (dBm)		1-g SA	AR (W/kg)		10-g SA	R (W/kg)	Plot
Technoligies	Antenna	Conditions	Mode	Mode	(mm)	Positio		Ch #.	(MHz		ycle	Tune-up Limit	Mea	as.	Meas.	Scale	d	Meas.	Scaled	No.
Bluetooth	ANT3 Pstandlaon	Hotspot	GFSK	Mode B	5	Edge 4	4	39	244	1 10	0.0%	19.50	18.	37	0.890	1.154	1	0.354	0.459	12

## 8.3. A2633 Spot Check Results

Wireless		RF Exposur	e	Pov	v er	Dist.	Test	t			Freq.		Pow er	r (dBm)		1-g SAI	R (W/kg	)	10-g SAI	R (W/kg)	Plot
Technoligies	Antenn	Conditions	Mode	Mo	ode	(mm)	Position	on	Ch #	ŧ.	(MHz)		e-up mit	Meas		Meas.	Scal	ed	Meas.	Scaled	No.
CDMA BC10	ANT2	Head	1xRTT RC SO55	Mod	le A	0	Right To	ouch	560		820.0	24	.70	24.62	!	0.976	0.99	94	0.633	0.645	13
														Pow er (d	IBm)	1-0	SAR (V	V/ka)	10-a S	AR (W/kg)	
Wireless Technoligies	Antenna	RF Exposure Conditions		Yow er Mode	Dist. (mm)	Te: Posi		Ch #.		req. MHz)	RB Allocation	RB offset		ne-up _imit	Meas.	Mea		Scaled	Meas.	Scaled	Plot No.
LTE B7	ANT2	Head	QPSK M	lode A	0	Left	Tilt	21100	) 25	535.0	50	24	1	7.70	16.68	0.70	18	0.895	0.260	0.329	14
														5 (	ID \		0.0			. 5 () 4 ()	
Wireless Technoligies	Antenna	RF Exposure Conditions		Power Mode	Dist. (mm)	Te: Posi		Ch #.		Freq. MHz)	RB Allocation	RB offset	Tu	Pow er (d			SAR (V		, i	AR (W/kg)	Plot No.
recrinoligies		Conditions		vioue	(11111)	FUSI	lion		(I	VIIIZ)	Allocation	onsei		_imit	Meas.	Mea	s.	Scaled	Meas.	Scaled	INO.
LTE B48	ANT7	Body-w orn	QPSK N	lode B	5	Re	ar	56640	36	590.0	1	49	2	0.40	19.77	0.71	5	0.827	0.239	0.276	15
										_	Area	Scan		Powe	er (dBm)		1-g SAR	(W/kg)	10-a	SAR (W/kg)	
Wireless Technoligies	Antenna I	WWAN RF Expo Pow er Conditi				Dist. (mm)	Test Position	C	Ch #.	Freq. (MHz)	Max	SAR	Duty Cycle	Tune-up Limit	Mea	ıs. M	leas.	Scaled	Meas.	Scaled	Plot No.
Wi-Fi 2.4 GHz	ANT4	Cell Off Hotsp	ot 802.11	o Mod	de B	5	Edge 2		6	2437	0.0	369 9	8.5%	21.50	19.	90 0	.726	1.065	0.310	0.455	16
												Area Scar			ow er (dB	m)	1 a S A	R (W/kg)	10.0	SAR (W/kg)	
Wireless Technoligies		WAN Pow er Band	RF Exposure Conditions	Mode				Test sition	Ch #			Max. SAR (W/kg)		у	up	Meas.	Meas.	Scale			Plot No.
Wi-Fi 5 GHz	ANT5 C	ell OFF U-NII-3	Body-w orn	802.11ac VHT80	Mo	de B	5 R	Rear	155		5775	1.450	95.1	% 16.2	5	14.44	0.662	1.056	0.203	0.324	17
Wireless		RF Exposure		Powe		ist.	Test			Fre		Duty	Po	ow er (dBn	1)	1-g S	SAR (W/I	kg)	10-g SA	R (W/kg)	Plot
Technoligies	Antenna	Conditions	Mode	Mode			Position	Ι'	Ch #.	(MH		Cycle	Tune-i	' I M	eas.	Meas.	Sc	aled	Meas.	Scaled	No.
Bluetooth	ANT3 Pstandlaon	Hotspot	GFSK	Mode	В	5	Edge 4		39	244	11 10	00.0%	19.50	) 18	3.37	0.754	0.	.978	0.308	0.400	18

### **Appendixes**

Refer to separated files for the following appendixes.

**Appendix A: SAR Setup Photos** 

**Appendix B: SAR System Check Plots** 

**Appendix C: SAR Highest Test Plots** 

**Appendix D: SAR Tissue Ingredients** 

**Appendix E: SAR Probe Certificates** 

**Appendix F: SAR Dipole Certificates** 

**END OF REPORT**